

Search Notes



Application/Control No.

10/667,316

Examiner

Anh T.N. Vo

Applicant(s)/Patent under Reexamination

HAYASHI ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
<i>updated search 05/06/06 AV</i>			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
347	86	5/2/2006	AV
	49	↓	↓

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR